



REPORT No. : SZ17040271E01

FCC TEST REPORT

APPLICANT : GREAT TALENT TECHNOLOGY LIMITED

PRODUCT NAME : Android device

MODEL NAME : TEL-TE-VR-U2

TRADE NAME : UMX

BRAND NAME : UMX

FCC ID : 2ALZM-TEL-TE-VR-U2

STANDARD(S) : 47 CFR Part 15 Subpart B

TEST DATE : 2017-05-02 to 2017-05-15

ISSUE DATE : 2017-05-16

SHENZHEN MORLAB COMMUNICATIONS TECHNOLOGY Co., Ltd.

NOTE: This document is issued by MORLAB, the test report shall not be reproduced except in full without prior written permission of the company. The test results apply only to the particular sample(s) tested and to the specific tests carried out which is available on request for validation and information confirmed at our website.

MORLAB GROUP

FL1-3, Building A, FeiYang Science Park, No.8 LongChang Road,
Block67, BaoAn District, ShenZhen , GuangDong Province, P. R. China

Tel: 86-755-36698555 Fax: 86-755-36698525
Http://www.morlab.cn E-mail: service@morlab.cn



DIRECTORY

<u>1. TECHNICAL INFORMATION</u>	<u>5</u>
1.1. APPLICANT INFORMATION	5
1.2. EQUIPMENT UNDER TEST (EUT) DESCRIPTION	5
<u>2. TEST RESULTS</u>	<u>6</u>
2.1. APPLIED REFERENCE DOCUMENTS	6
<u>3. TEST CONDITIONS SETTING</u>	<u>7</u>
3.1. TEST MODE	7
3.2. TEST SETUP AND EQUIPMENTS LIST	8
3.2.1. CONDUCTED EMISSION	8
3.2.2. RADIATED EMISSION	9
<u>4. 47 CFR PART 15B REQUIREMENTS</u>	<u>11</u>
4.1. CONDUCTED EMISSION	11
4.1.1. REQUIREMENT	11
4.1.2. TEST DESCRIPTION	11
4.1.3. TEST RESULT	11
4.2. RADIATED EMISSION	14
4.2.1. REQUIREMENT	14
4.2.2. TEST DESCRIPTION	14
4.2.3. FREQUENCY RANGE OF MEASUREMENT	14
4.2.4. TEST RESULT	15
<u>ANNEX A TEST SETUP PHOTOS</u>	<u>18</u>
<u>ANNEX B TEST UNCERTAINTY</u>	<u>20</u>
<u>ANNEX C TESTING LABORATORY INFORMATION</u>	<u>21</u>



REPORT No. : SZ17040271E01

1.	IDENTIFICATION OF THE RESPONSIBLE TESTING LABORATORY	21
2.	IDENTIFICATION OF THE RESPONSIBLE TESTING LOCATION	21
3.	ACCREDITATION CERTIFICATE	21
4.	TEST ENVIRONMENT CONDITIONS	21

Change History		
Issue	Date	Reason for change
1.0	2017-05-16	First edition



Test Report Declaration

Applicant	GREAT TALENT TECHNOLOGY LIMITED
Applicant Address	RM602,T3 Software Park,Nanshan,Shenzhen,China
Manufacturer	SIM Technology Group Limited
Manufacturer Address	NO.888 Shengli Road QingPu District Shanghai
Product Name	Android device
Model Name	TEL-TE-VR-U2
Brand Name	UMX
HW Version	V1.0
SW Version	Andiod V7.1.1
Test Standards	47 CFR Part 15 Subpart B
Test Result	PASS

Tested by : Peng Shiqing
Peng Shiqing

Approved by : Xiao Xiong
Xiao Xiong



1. Technical Information

Note: Provided by applicant

1.1. Applicant Information

Company: GREAT TALENT TECHNOLOGY LIMITED
Address: RM602,T3 Software Park,Nanshan,Shenzhen,China

1.2. Equipment under Test (EUT) Description

EUT Type:	Android device	
Serial No:	(N/A, marked #1 by test site)	
Hardware Version:	V1.0	
Software Version:	Andiod V7.1.1	
Power supply:	Battery	
	Brand Name:	Jiade
	Model No.:	6PX501(JKK-L)
	Serial No.:	(N/A, marked #1 by test site)
	Capacity:	3095mAh
	Rated Voltage:	3.85V
	Charge Limit:	4.40V
Ancillary Equipment :	AC Adapter (Charger for Battery)	
	Brand Name:	SHE
	Model No.:	P12DUSB050100 US
	Serial No.:	(N/A, marked #1 by test site)
	Rated Input:	~ 100-240V, 50/60Hz,300mA
	Rated Output:	≡ 5.0V, 1.0A

NOTE:

1. The EUT is an Android device which supports 5.8GHz SRD, ISM 2.4GHz Bluetooth band and WIFI (802.11a/b/g/n/ac) band.
2. It is equipped with a Type-C port which can be connected to the ancillary equipments.
3. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer.



2. Test Results

2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Result
1	15.107	Conducted Emission	2017.05.05	PASS
2	15.109	Radiated Emission	2017.05.08	PASS

NOTE: The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.



3. Test Conditions Setting

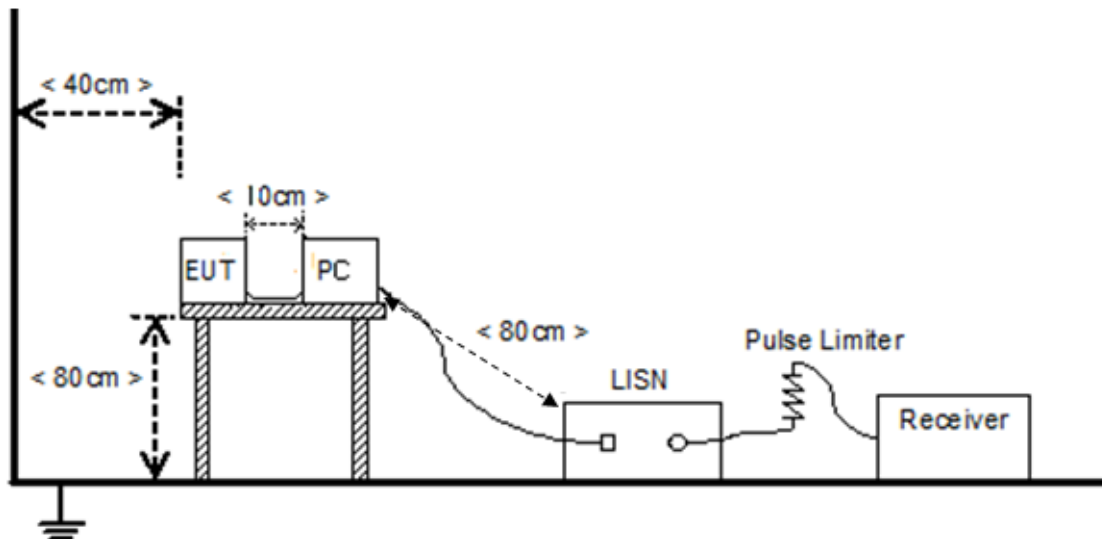
3.1. Test Mode

1	The first test mode (Data Transmitting)
	The EUT configuration of the emission tests is EUT + Battery + PC. In this test mode, the EUT was connected to a PC via the Type-C port. During the measurement, the data is transmitting between the PC and the EUT.
2	The second test mode (MP4)
	The EUT configuration of the emission tests is EUT + Battery + Charger. During the test, the MP4 function was active.
3	The third test mode (Camera)
	The EUT configuration of the emission tests is EUT + Battery + Charger. During the test, the Camera function was active.
Note: All the test modes are performed, only the worst case (Data Transmitting) is recorded in this report.	

3.2. Test Setup and Equipments List

3.2.1. Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides 50Ω/50μH of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

The power strip or extension cord has been investigated to make sure that the LISN integrity is maintained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 at Clause 4.3.

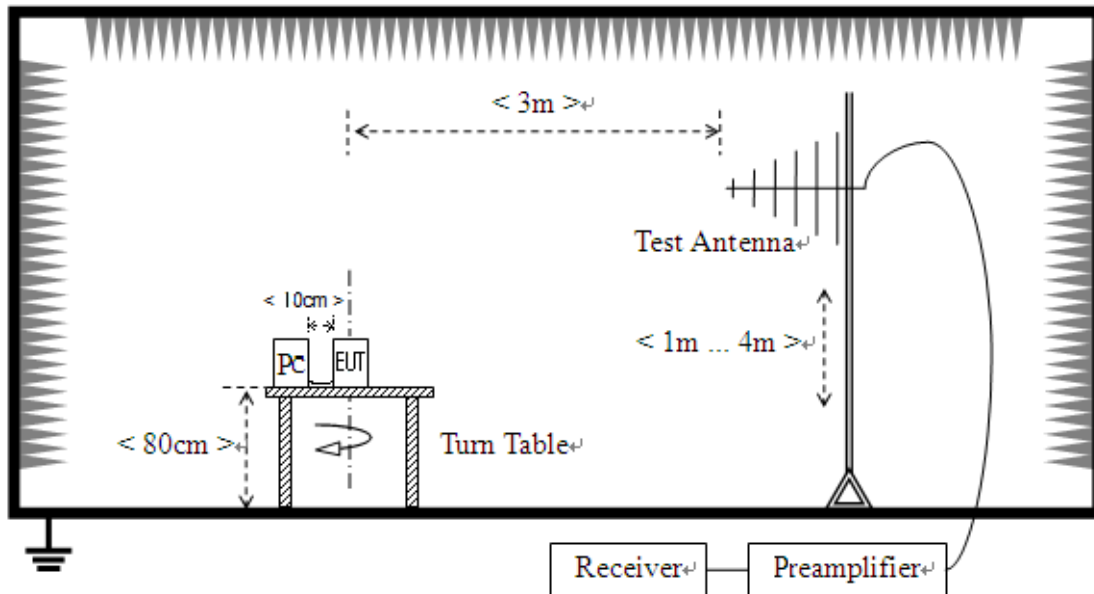
B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
Receiver	Narda	PMM 9010	595WX11007	2016.06.02	2017.06.01
LISN	Schwarzbeck	NSLK 8127	812744	2016.06.02	2017.06.01
Pulse Limiter (20dB)	VTSD	9561D	9537	2016.07.05	2017.07.04
PC	Apple	A1370	C02FQ2PYD DQW	N/A	N/A

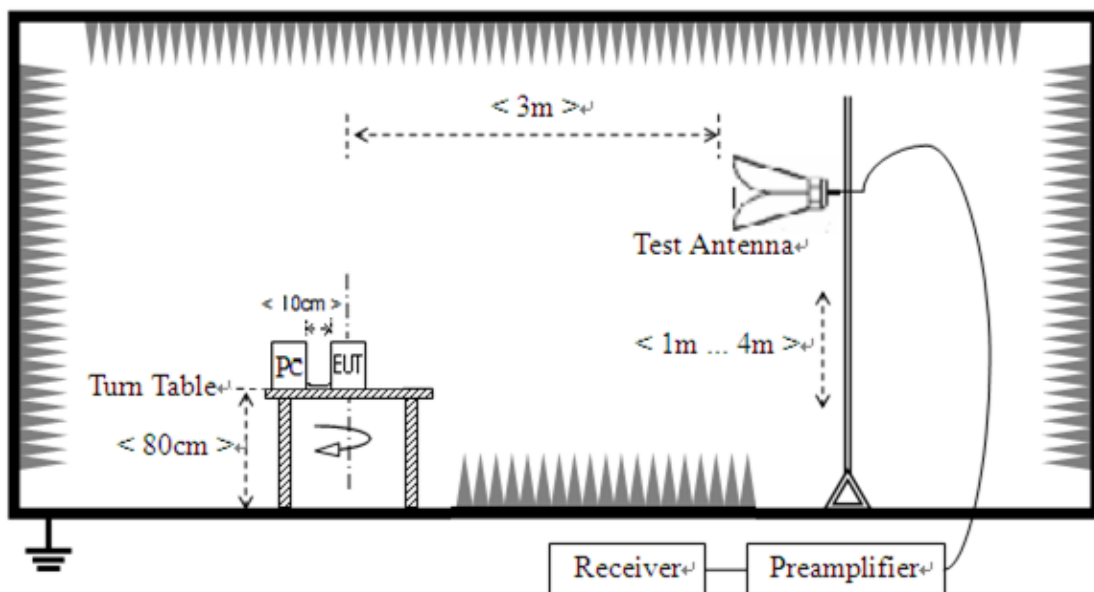
3.2.2. Radiated Emission

A. Test Setup:

1. For radiated emissions from 30MHz to 1GHz



2. For radiated emissions above 1GHz



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of



the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
MXE EMI Receiver	Agilent	N9038A	MY54130016	2016.06.03	2017.06.02
Semi-Anechoic Chamber	Changning	9m*6m*6m	N/A	2017.01.11	2018.01.10
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-274	2016.12.09	2017.12.08
Test Antenna - Horn	Schwarzbeck	BBHA9120C	9120C-384	2016.07.05	2017.07.04
18-26.5GHz pre-Amplifier	MA03	TS-PR18	Rohde&Schwarz	2016.03.02	2017.03.01
26.5-40GHz pre-Amplifier	C00990	NSP4000-SP2	Miteq	2016.03.02	2017.03.01
PC	Apple	A1370	C02FQ2PYD DQW	N/A	N/A

4. 47 CFR Part 15B Requirements

4.1. Conducted Emission

4.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

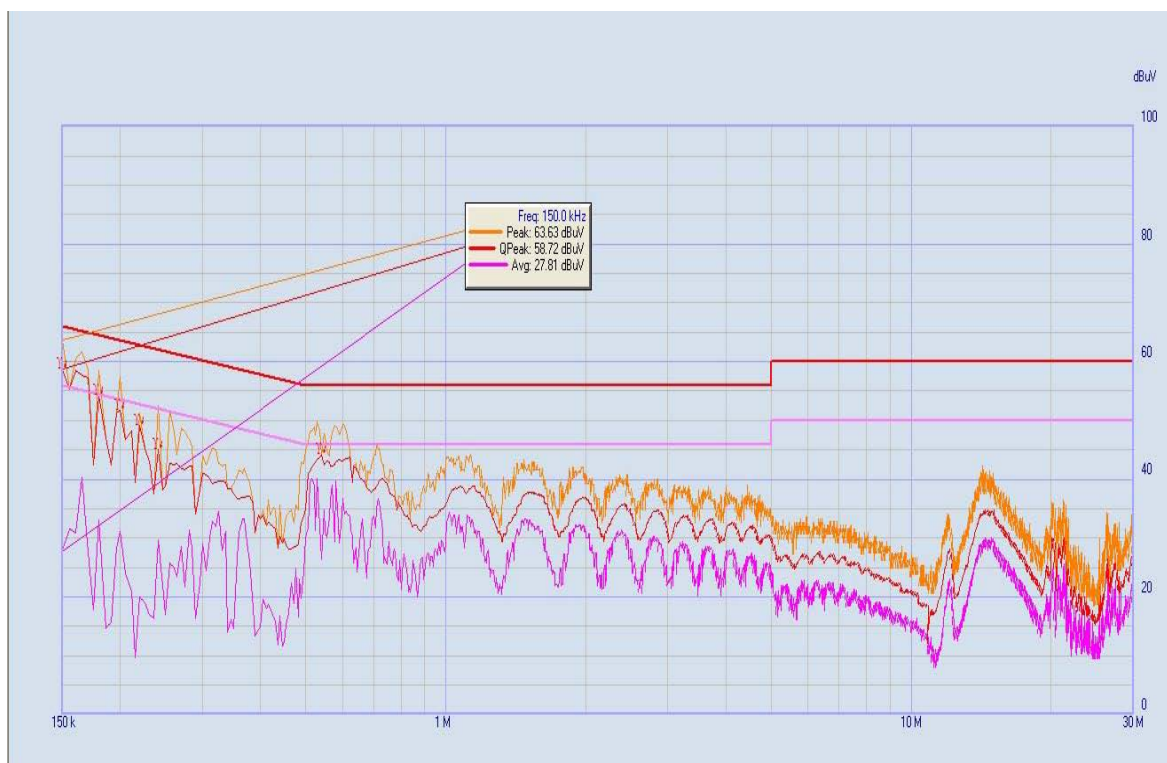
4.1.2. Test Description

See section 3.2.1 of this report.

4.1.3. Test Result

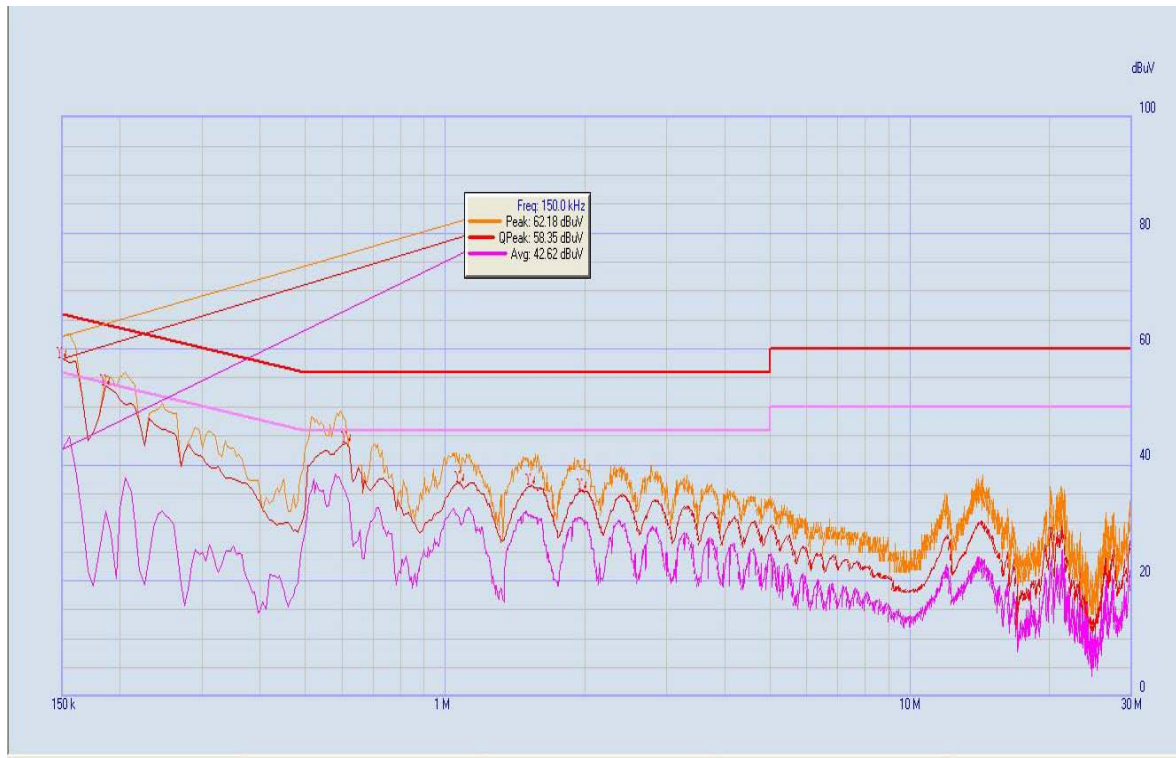
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

A. Test Plot and Suspicious Points:



(Plot A: L Phase)

No.	Fre. (MHz)	Emission Level (dBμV)		Limit (dBμV)		Power-line	Verdict
		Quai-peak	Average	Quai-peak	Average		
1	0.15	58.72	27.81	66.00	56.00	Line	PASS
2	0.18	54.20	33.15	65.14	55.14		PASS
3	0.20	51.61	31.17	64.57	54.57		PASS
4	0.22	49.01	19.94	64.00	54.00		PASS
5	0.24	44.95	29.56	63.43	53.43		PASS
6	0.54	44.09	26.32	56.00	46.00		PASS



(Plot B: N Phase)

No.	Fre. (MHz)	Emission Level (dBμV)		Limit (dBμV)		Power-line	Verdict
		Quai-peak	Average	Quai-peak	Average		
1	0.15	58.35	42.62	66.00	56.00	Neutral	PASS
2	0.185	53.68	32.03	65.00	55.00		PASS
3	0.615	43.74	34.75	56.00	46.00		PASS
4	1.075	37.01	29.79	56.00	46.00		PASS
5	1.525	36.17	31.31	56.00	46.00		PASS
6	1.97	35.49	30.58	56.00	46.00		PASS

Result: Pass

4.2. Radiated Emission

4.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength Limitation at 3m Measurement Dist	
	($\mu\text{V/m}$)	(dB $\mu\text{V/m}$)
30.0 - 88.0	100	20log 100
88.0 - 216.0	150	20log 150
216.0 - 960.0	200	20log 200
Above 960.0	500	20log 500

As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dB $\mu\text{V/m}$ is calculated by $20\log$ Emission Level($\mu\text{V/m}$).

4.2.2. Test Description

See section 3.2.2 of this report.

4.2.3. Frequency range of measurement

According to 15.33(b)(1), the frequency range of radiated measurement for the EUT is listed in the following table:



Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 1.705	30.
1.705-108	1000.
108-500	2000.
500-1000	5000.
Above 1000	5th harmonic of the highest frequency or 40 GHz, whichever is lower.

4.2.4. Test Result

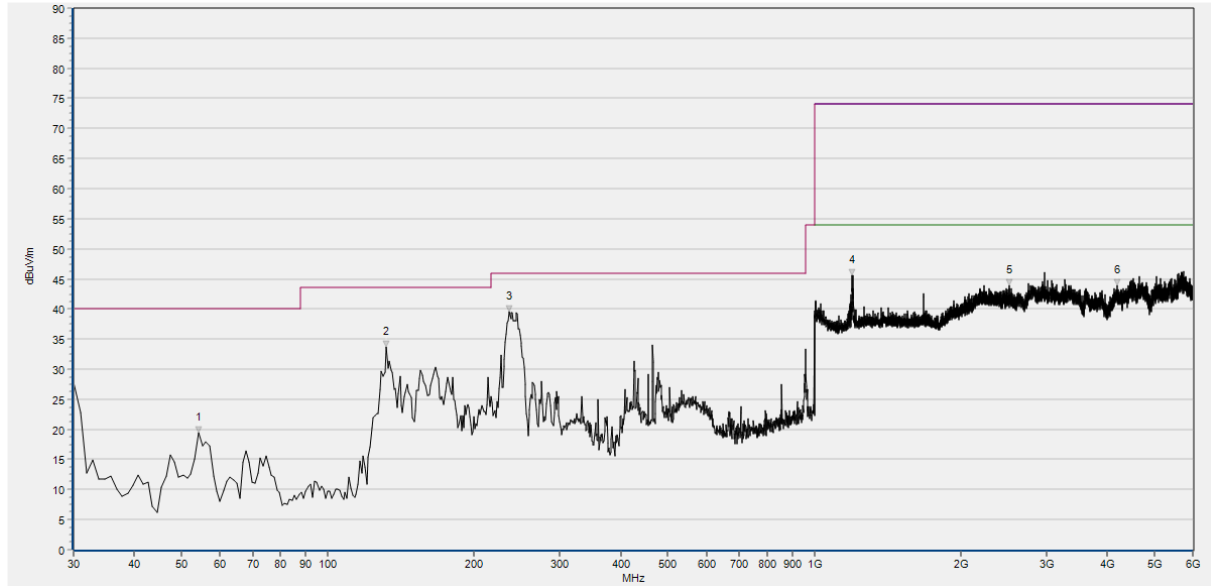
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions (6GHz-30GHz) which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

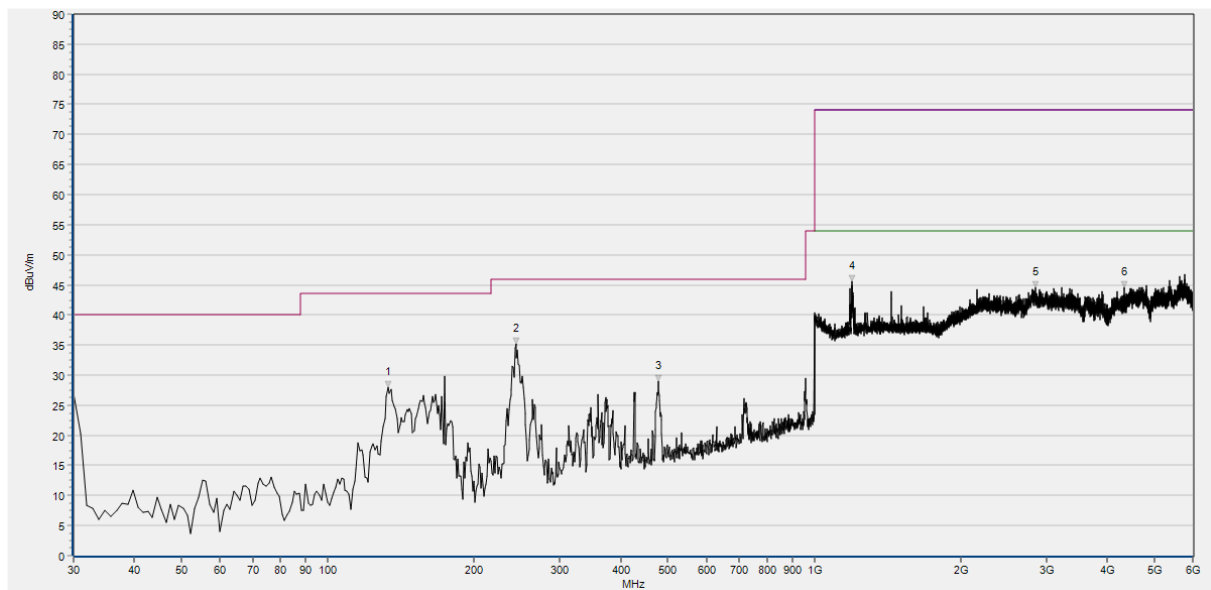


A. Test Plots and Suspicious Points:



(Plot A: 30MHz – 6GHz, Test Antenna Vertical)

No.	Fre. MHz	Pk dBμV/m	QP dBμV/m	AV dBμV/m	Limit-PK dBμV/m	Limit-QP dBμV/m	Limit-AV dBμV/m	ANT	Verdict
1	54.250	N.A.	19.43	N.A.	N.A.	40.00	N.A.	V	PASS
2	131.850	N.A.	33.63	N.A.	N.A.	43.50	N.A.	V	PASS
3	235.640	N.A.	39.55	N.A.	N.A.	46.00	N.A.	V	PASS
4	1195.733	45.66	N.A.	39.25	74.00	N.A.	54.00	V	PASS
5	2512.533	43.85	N.A.	37.76	74.00	N.A.	54.00	V	PASS
6	4200.000	43.87	N.A.	37.11	74.00	N.A.	54.00	V	PASS



(Plot B: 30MHz – 6GHz, Test Antenna Horizontal)

No.	Fre. MHz	Pk dBμV/m	QP dBμV/m	AV dBμV/m	Limit-PK dBμV/m	Limit-QP dBμV/m	Limit-AV dBμV/m	ANT	Verdict
1	132.820	N.A.	28.01	N.A.	N.A.	43.50	N.A.	H	PASS
2	243.400	N.A.	35.11	N.A.	N.A.	46.00	N.A.	H	PASS
3	478.140	N.A.	28.93	N.A.	N.A.	46.00	N.A.	H	PASS
4	1195.733	45.54	N.A.	39.17	74.00	N.A.	54.00	H	PASS
5	2848.320	44.54	N.A.	38.69	74.00	N.A.	54.00	H	PASS
6	4340.800	44.50	N.A.	38.04	74.00	N.A.	54.00	H	PASS

Result: Pass

Annex A Test Setup Photos

1. Conducted emission main's port front view



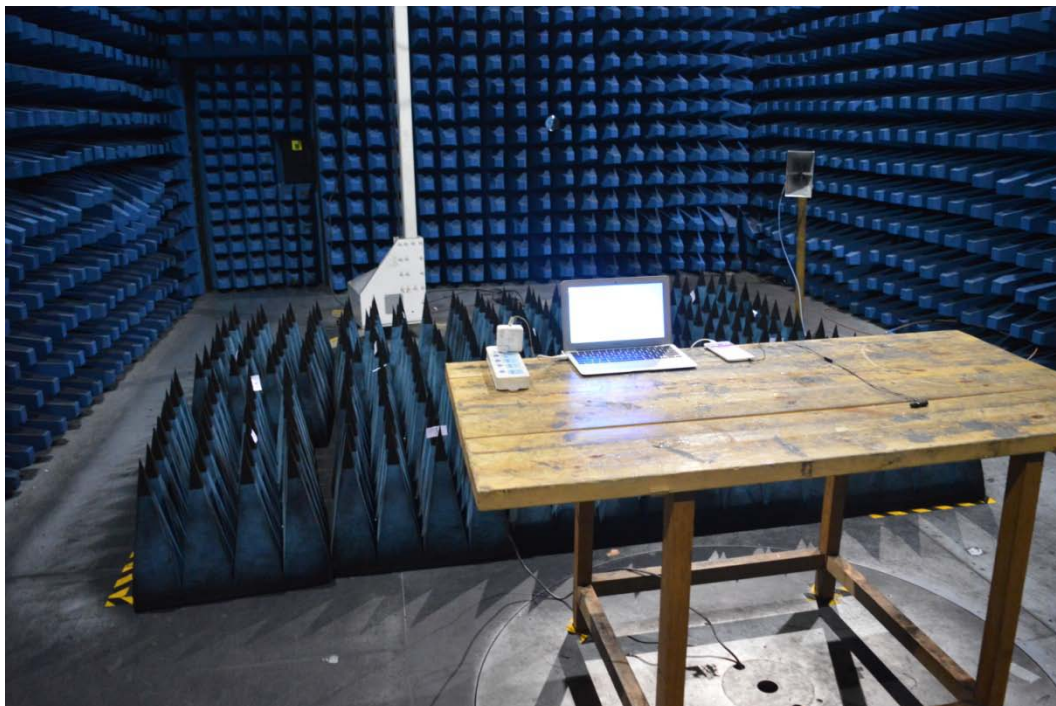
2. Conducted emission main's port side view



3. Radiated emission (30MHz-1GHz)



4. Radiated emission (above 1GHz)





Annex B Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	$\pm 1.8\text{dB}$
Uncertainty of Radiated Emission:	$\pm 3.1\text{dB}$



Annex C Testing Laboratory Information

1. Identification of the Responsible Testing Laboratory

Company Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Department:	Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China
Responsible Test Lab Manager:	Mr. Su Feng
Telephone:	+86 755 36698555
Facsimile:	+86 755 36698525

2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China

3. Accreditation Certificate

Accredited Testing Laboratory: The FCC registration number is 695796.
(Shenzhen Morlab Communications Technology Co., Ltd.)

4. Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106

***** END OF REPORT *****